Notice of References Cited Application/Control No. 10/567,710 Applicant(s)/Patent Under Reexamination NISHIO ET AL. Examiner ALEXANDER C. WITKOWSKI 2853 Applicant(s)/Patent Under Reexamination NISHIO ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,096,468 A	08-2000	Ohno et al.	430/108.3
*	В	US-6,328,393 B1	12-2001	Lin et al.	347/1
*	С	US-6,340,216 B1	01-2002	Peeters et al.	347/21
	D	US-			
	Е	US-			
	F	US-			
	G	US-			
	Н	US-			
	ı	US-			
	J	US-			
	K	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 56098172 A	08-1981	Japan	SATO, TSUTOMU	B41J 03/04
	0					
	Р					
	Q					
	R					
	S					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	w	
	×	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.